

**N-CHANNEL MOSFET**

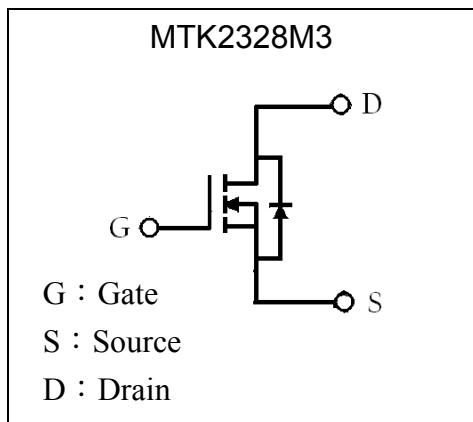
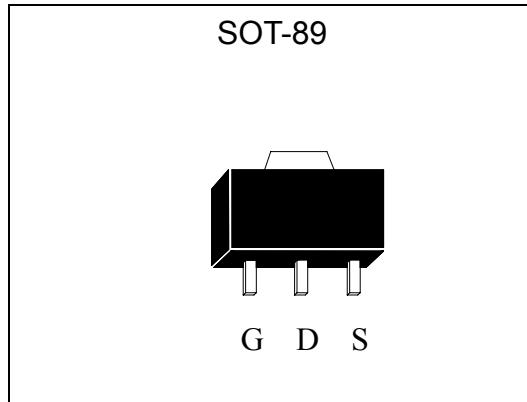
<b>BVDSS</b>	<b>100V</b>
<b>ID@VGS=10V, TA=25°C</b>	<b>3A</b>
<b>RDS(ON)@VGS=10V, ID=3A</b>	<b>130mΩ (typ)</b>
<b>RDS(ON)@VGS=4.5V, ID=3A</b>	<b>136mΩ (typ)</b>

**Description**

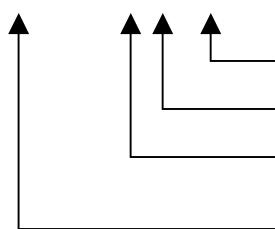
The MTK2328M3 is a N-channel enhancement-mode MOSFET.

**Features**

- Low on-resistance
- High speed switching
- Low-voltage drive
- Easily designed drive circuits
- Pb-free lead plating package

**Symbol****Outline****Ordering Information**

Device	Package	Shipping
MTK2328M3-0-T2-G	SOT-89 (Pb-free lead plating and halogen-free package)	1000 pcs / tape & reel



Environment friendly grade : S for RoHS compliant products, G for RoHS compliant and green compound products

Packing spec, T2 : 1000 pcs / tape & reel, 7" reel

Product rank, zero for no rank products

Product name

**Absolute Maximum Ratings (Ta=25°C)**

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V <sub>DSS</sub>	100	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	
Continuous Drain Current @V <sub>GS</sub> =10V, T <sub>A</sub> =25°C	I <sub>D</sub>	3	A
Continuous Drain Current @V <sub>GS</sub> =10V, T <sub>A</sub> =100°C		1.9	
Pulsed Drain Current	I <sub>DM</sub>	12 *1	W
Total Power Dissipation	P <sub>D</sub>	2.1 *2	
Operating Junction and Storage Temperature Range	T <sub>j</sub> ; T <sub>tsg</sub>	-55~+150	°C

Note : \*1. Pulse Width ≤ 300μs, Duty cycle ≤2%

\*2. When the device is surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board with 2 oz. copper.**Thermal Performance**

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient	R <sub>th,ja</sub>	60	°C/W

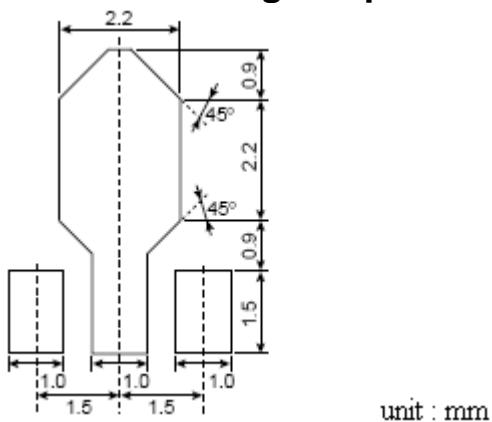
Note : Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board.**Electrical Characteristics (Ta=25°C)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
<b>Static</b>						
BV <sub>DSS</sub> *	100	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =10μA	
V <sub>GS(th)</sub>	1	1.8	2.5		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V	
R <sub>DS(ON)*</sub>	-	130	150	mΩ	I <sub>D</sub> =3A, V <sub>GS</sub> =10V	
	-	136	160		I <sub>D</sub> =3A, V <sub>GS</sub> =4.5V	
G <sub>FS</sub>	-	5	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =3A	
<b>Dynamic</b>						
C <sub>iss</sub>	-	1188	-	pF	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1MHz	
C <sub>oss</sub>	-	30	-			
C <sub>rss</sub>	-	17	-			
t <sub>d(ON)</sub>	-	7	-	ns	V <sub>DS</sub> =50V, I <sub>D</sub> =3A, V <sub>GS</sub> =10V, R <sub>GEN</sub> =6Ω	
t <sub>r</sub>	-	3.2	-			
t <sub>d(OFF)</sub>	-	29	-			
t <sub>f</sub>	-	5	-			
Q <sub>g</sub>	-	18.4	-	nC	V <sub>DS</sub> =50V, I <sub>D</sub> =3A, V <sub>GS</sub> =10V	
Q <sub>gs</sub>	-	4	-			
Q <sub>gd</sub>	-	7.5	-			
<b>Source-Drain Diode</b>						
*I <sub>S</sub>	-	-	3	A		
*I <sub>SM</sub>	-	-	12			

*V <sub>SD</sub>	-	-	1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =3A
*t <sub>rr</sub>	-	45	-	ns	
*Q <sub>rr</sub>	-	70	-	nC	I <sub>F</sub> =3A, dI <sub>F</sub> /dt=100A/μs

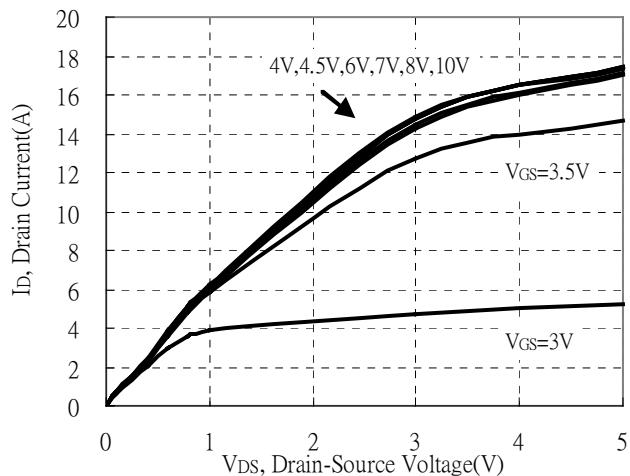
\*Pulse Test : Pulse Width ≤380μs, Duty Cycle≤2%

### Recommended soldering footprint

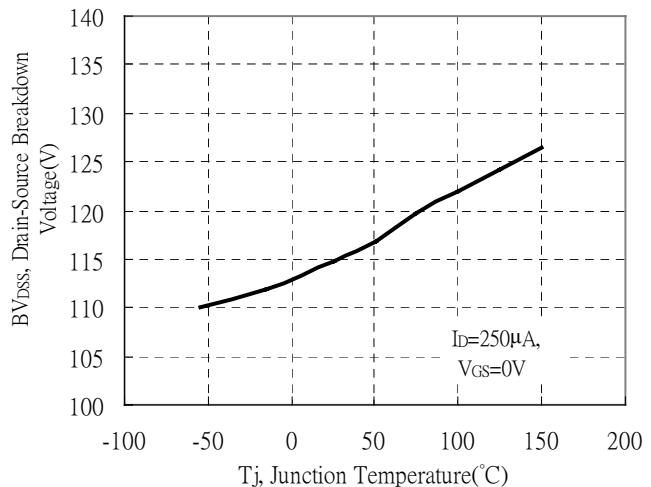


## Typical Characteristics

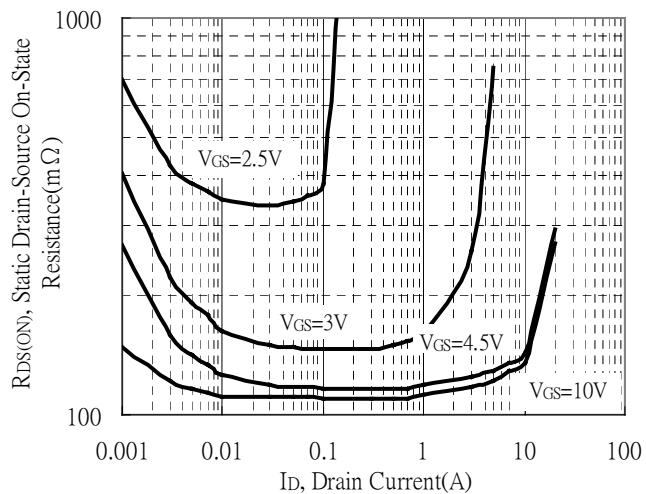
Typical Output Characteristics



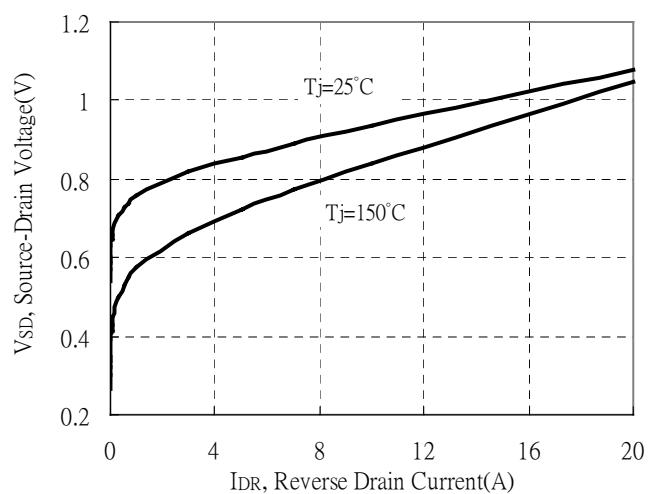
Breakdown Voltage vs Ambient Temperature



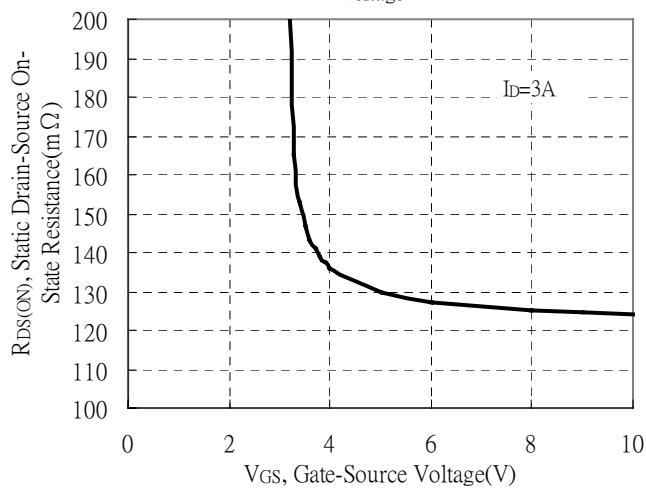
Static Drain-Source On-State resistance vs Drain Current



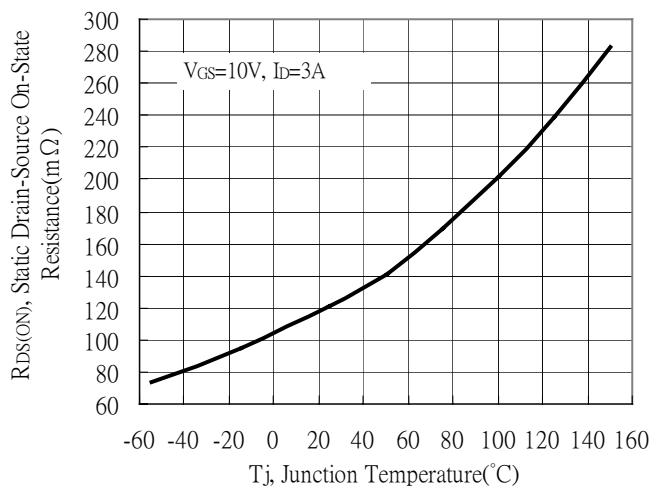
Reverse Drain Current vs Source-Drain Voltage



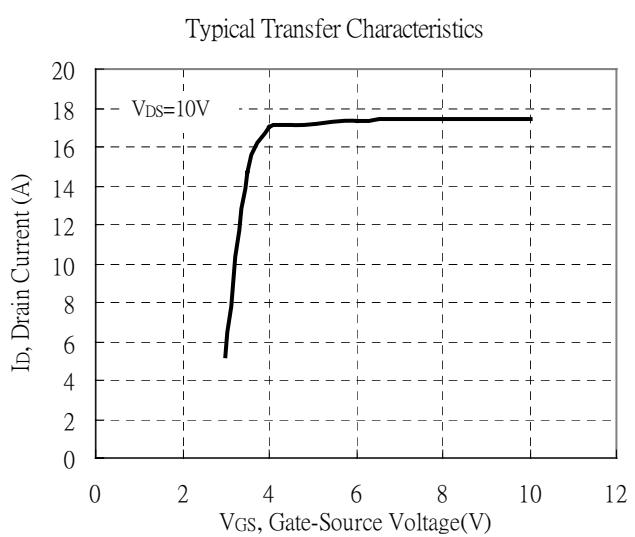
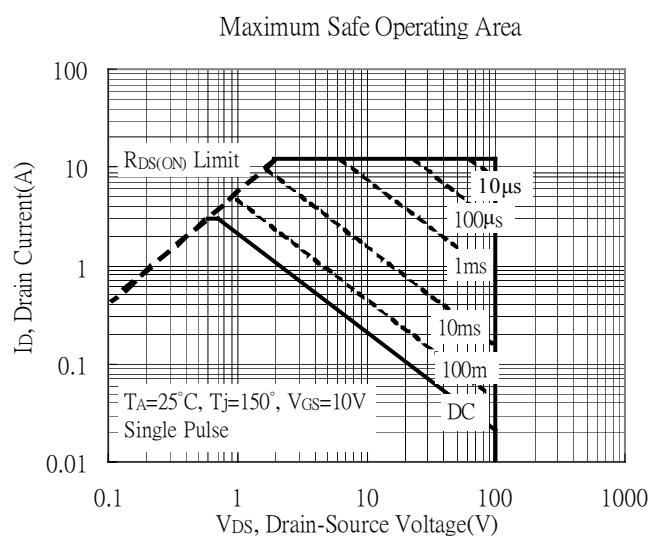
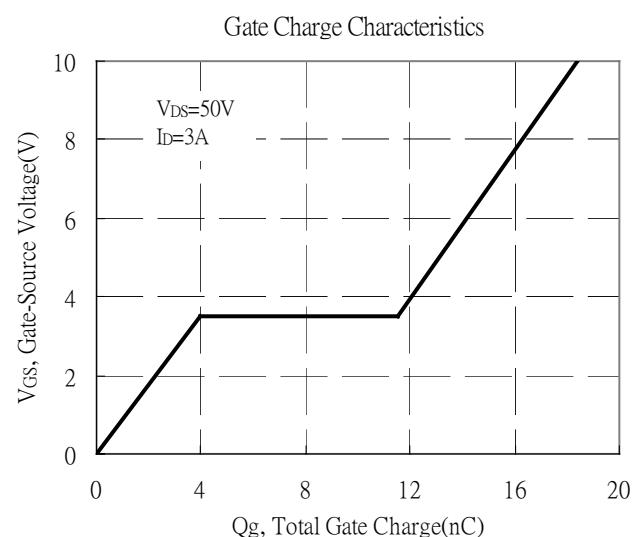
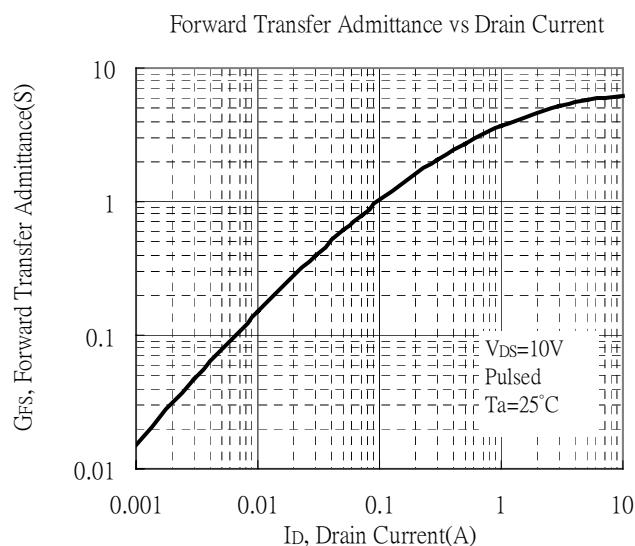
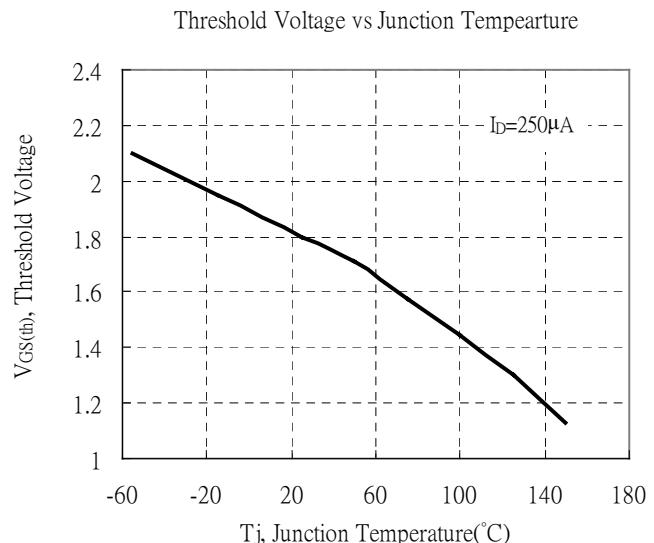
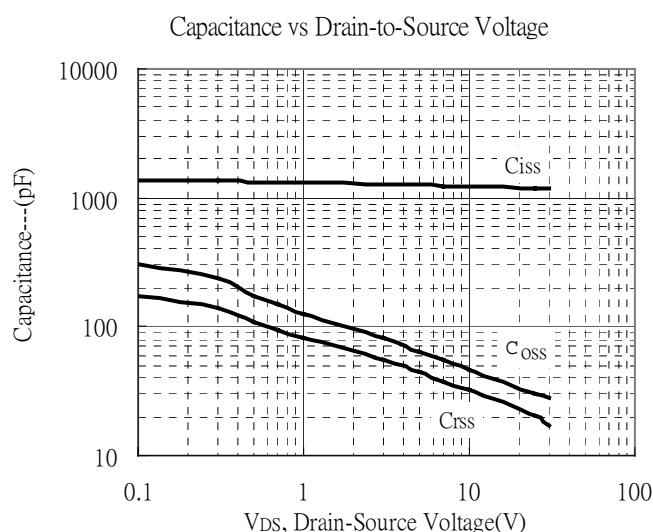
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

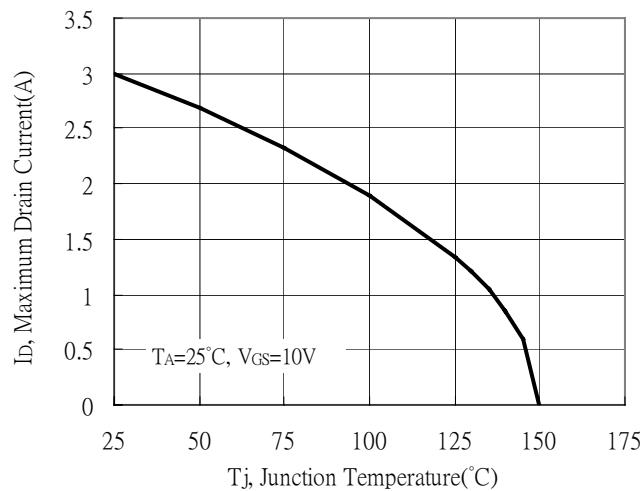


## Typical Characteristics(Cont.)

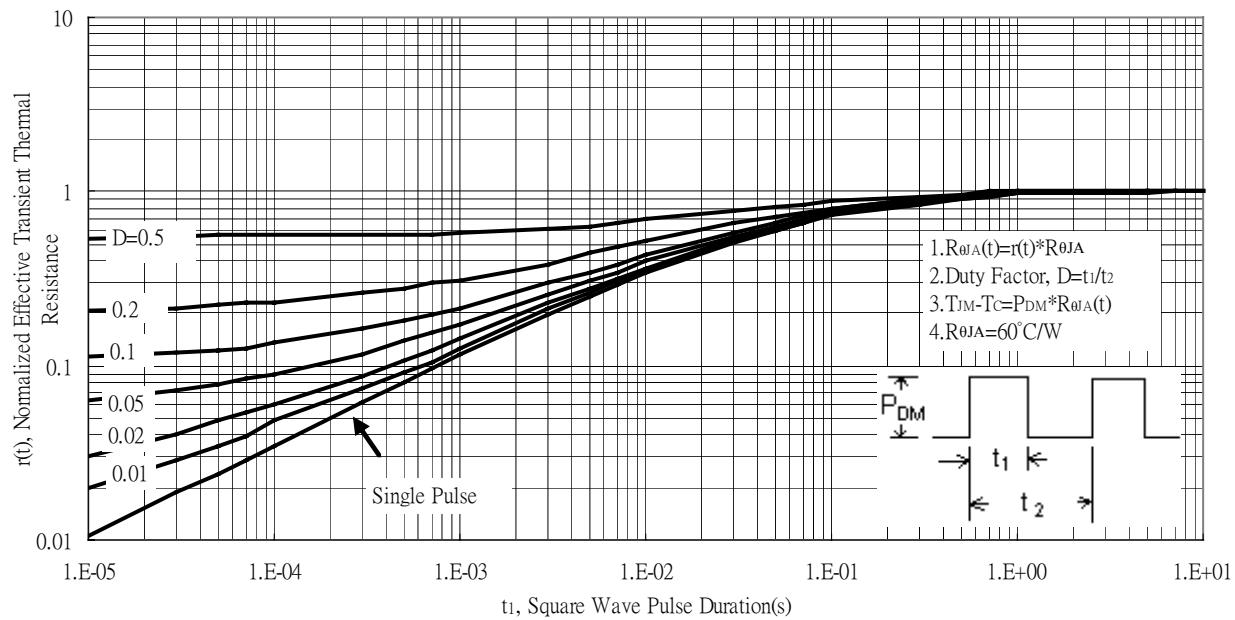


## Typical Characteristics(Cont.)

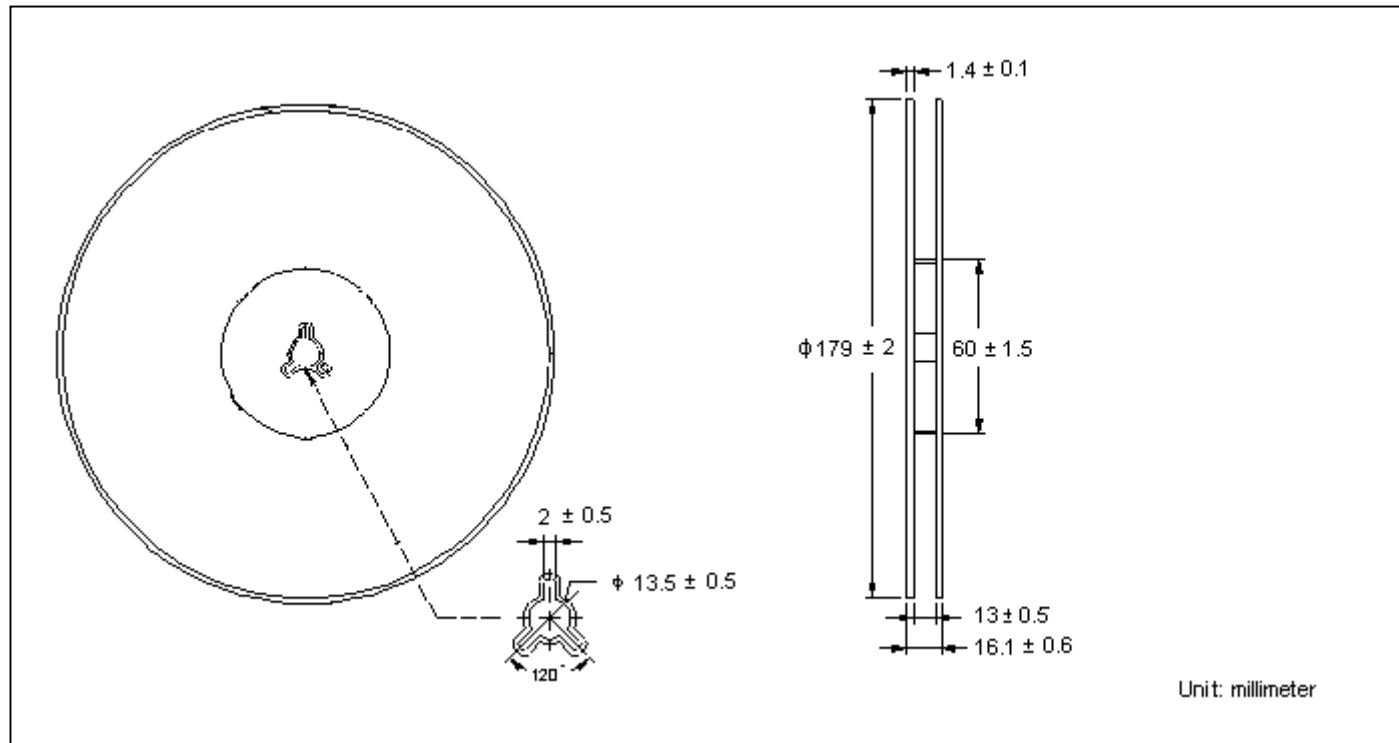
Maximum Drain Current vs Junction Temperature



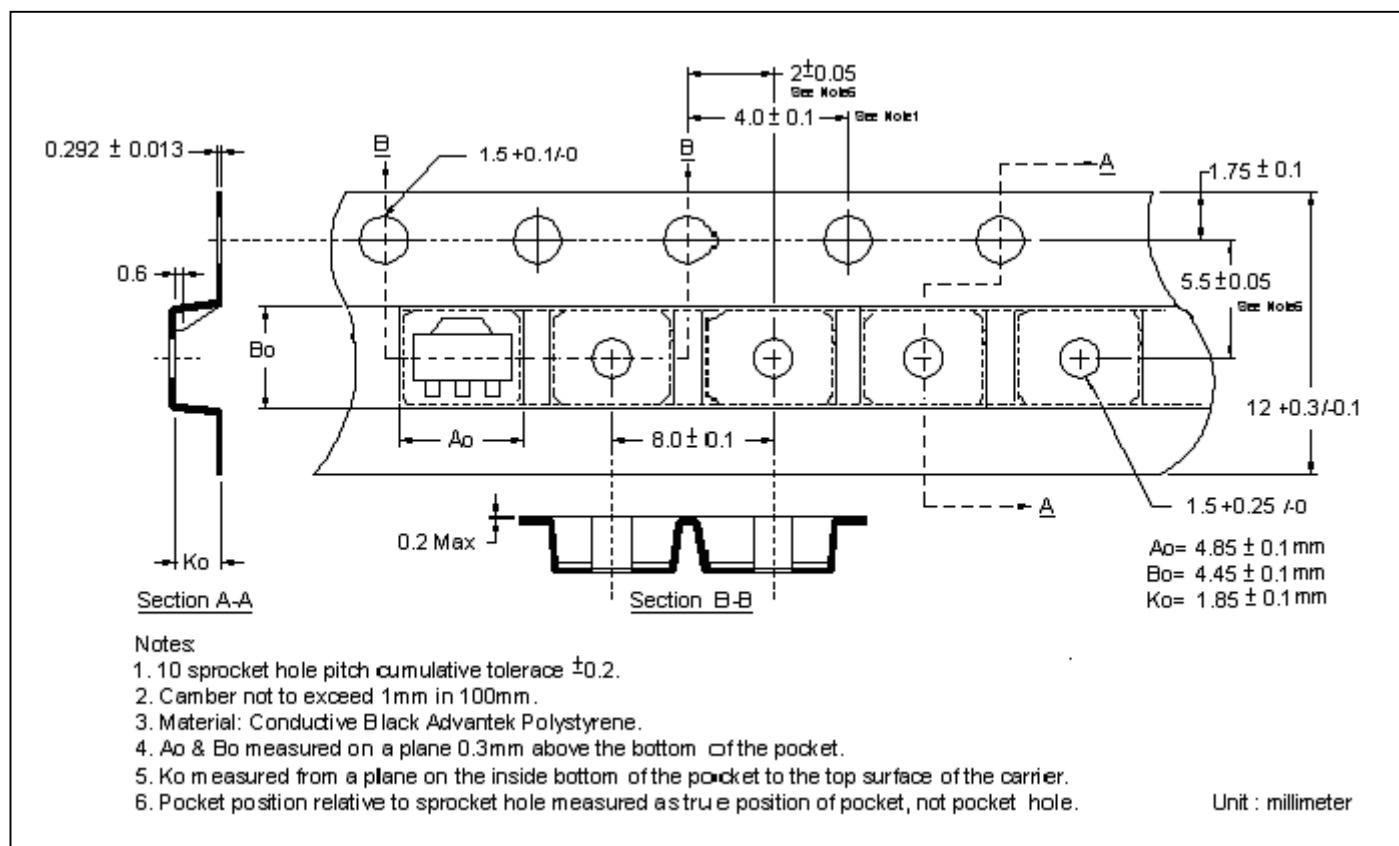
Transient Thermal Response Curves



## Reel Dimension

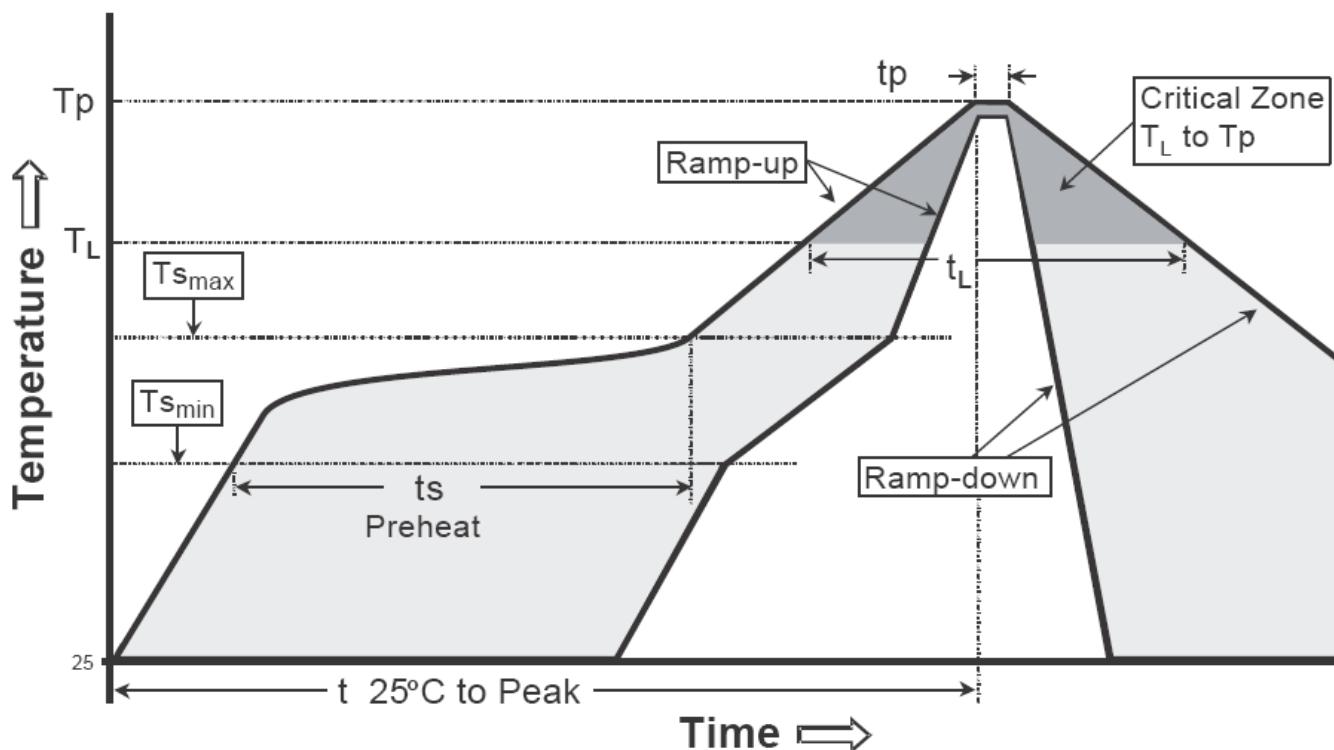


## Carrier Tape Dimension



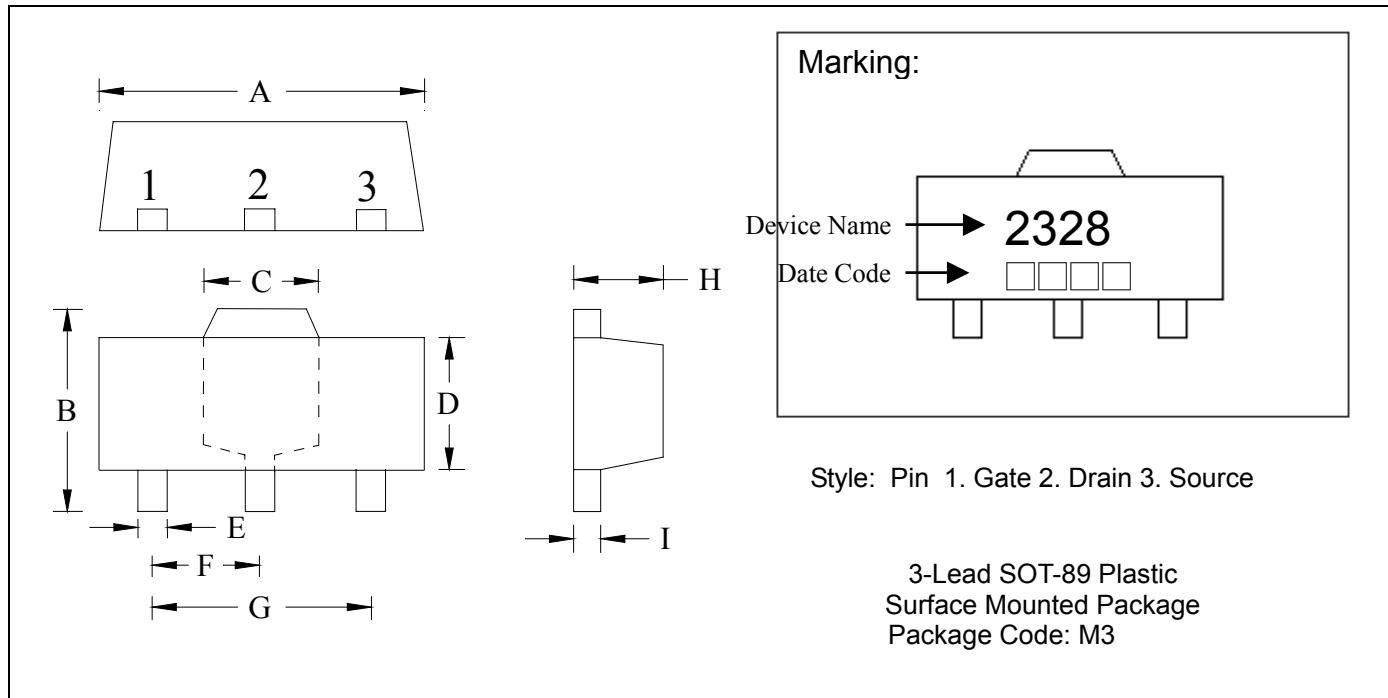
**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended temperature profile for IR reflow**

Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate ( $T_{s\max}$ to $T_p$ )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min( $T_s$ min)	100°C	150°C
-Temperature Max( $T_s$ max)	150°C	200°C
-Time( $t_{s\min}$ to $t_{s\max}$ )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature ( $T_L$ )	183°C	217°C
- Time ( $t_L$ )	60-150 seconds	60-150 seconds
Peak Temperature( $T_p$ )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature( $t_p$ )	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**SOT-89 Dimension**

\*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1732	0.1811	4.40	4.60	F	0.0591	TYP	1.50	TYP
B	0.1551	0.1673	3.94	4.25	G	0.1181	TYP	3.00	TYP
C	0.0610	REF	1.55	REF	H	0.0551	0.0630	1.40	1.60
D	0.0906	0.1024	2.30	2.60	I	0.0138	0.0173	0.35	0.44
E	0.0126	0.0205	0.32	0.52					

Notes: 1. Controlling dimension: millimeters.

2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.